


<b>Search Notes</b>  	<b>Application/Control No.</b>  10767082	<b>Applicant(s)/Patent Under Reexamination</b>  YUN ET AL.
	<b>Examiner</b>  Khan, Ibrahim A	<b>Art Unit</b>  2617

### SEARCHED

Class	Subclass	Date	Examiner
370	280/281	01/24/2007	IAK
370	331	01/24/2007	IAK
370	328, 338	5/16/2008	CMB
455	67.11, 67.13, 63.1, 436, 444	5/16/2008	CMB

### SEARCH NOTES

Search Notes	Date	Examiner
EASTImage and keyword search in USPAT, US-PGPUB, DERWENT, EPO, IBM TDB (see attached search strategy)	01/24/2007	IAK
Updated Search	5/16/2008	CMB

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner